

Search Notes

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Examiner

Frederick J. Parker

Applicant(s)/Patent under
Reexamination

WEI ET AL.

Art Unit

1762

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST update	10/16/06	JP